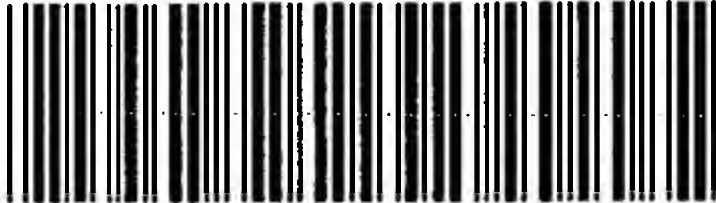


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/708,355	HSIEH, HSIANG-AN	
	Examiner	Art Unit	
	Yaima Campos	2185	

SEARCHED			
Class	Subclass	Date	Examiner
711	103	8/14/2006	YC
711	115	8/14/2006	YC
711	118	8/14/2006	YC

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Consulted Primary Examiner Reginald Bragdon	8/14/2006	YC
Updated EAST search	8/14/2006	YC